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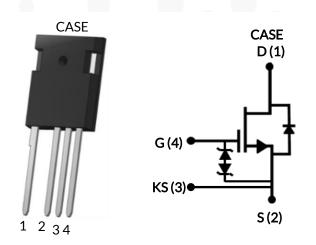
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DATASHEET

UF4C120070K4S



Part Number	Package	Marking
UF4C120070K4S	TO-247-4L	UF4C120070K4S



Silicon Carbide (SiC) Cascode JFET -EliteSiC, Power N-Channel, TO-247-4L, 1200 V, 72 mohm

Rev. B, January 2025

Description

The UF4C120070K4S is a 1200V, $72m\Omega$ G4 SiC FET. It is based on a unique 'cascode' circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device's standard gate-drive characteristics allows for a true "drop-in replacement" to Si IGBTs, Si FETs, SiC MOSFETs or Si superjunction devices. Available in the TO-247-4L package, this device exhibits ultra-low gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads and any application requiring standard gate drive.

Features

- On-resistance R_{DS(on)}: 72mΩ (typ)
- Operating temperature: 175°C (max)
- Excellent reverse recovery: Q_{rr} = 119nC
- Low body diode V_{FSD}: 1.43V
- Low gate charge: Q_G = 37.8nC
- Threshold voltage V_{G(th)}: 4.8V (typ) allowing 0 to 15V drive
- Low intrinsic capacitance
- ESD protected: HBM class 2 and CDM class C3
- TO-247-4L package for faster switching, clean gate waveforms

Typical applications

- EV charging
- PV inverters
- Switch mode power supplies
- Power factor correction modules
- Motor drives
- Induction heating





Maximum Ratings

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	V _{DS}		1200	V
Cata course valtage	V _{GS} —	DC	-20 to +20	V
Gate-source voltage	V _{GS}	AC (f > 1Hz)	-25 to +25	V
Cartinuary durin annuart 1	1	T _C = 25°C	27.5	А
Continuous drain current ¹	I _D	T _C = 100°C	20.7	А
Pulsed drain current ²	I _{DM}	T _C = 25°C	83	А
Single pulsed avalanche energy ³	E _{AS}	L=15mH, I _{AS} =2.2A	36	mJ
SiC FET dv/dt ruggedness	dv/dt	$V_{DS} \le 800V$	200	V/ns
Power dissipation	P _{tot}	T _C = 25°C	217	W
Maximum junction temperature	T _{J,max}		175	°C
Operating and storage temperature	T _J , T _{STG}		-55 to 175	°C
Max. lead temperature for soldering, 1/8" from case for 5 seconds	TL		250	°C

1. Limited by $T_{J,max}$

2. Pulse width t_p limited by $T_{J,max}$

3. Starting $T_J = 25^{\circ}C$

Thermal Characteristics

Parameter	Symbol	Test Conditions	Value			1 Index
			Min	Тур	Max	- Units
Thermal resistance, junction-to-case	$R_{\theta JC}$			0.53	0.69	°C/W



Electrical Characteristics (T_J = +25°C unless otherwise specified)

Typical Performance - Static

Parameter	Cumbal	Test Conditions	Value			Linte
	Symbol	lest Conditions	Min	Тур	Max	- Units
Drain-source breakdown voltage	BV _{DS}	V _{GS} =0V, I _D =1mA	1200			V
Total drain leakage current		V _{DS} =1200V, V _{GS} =0V, T _J =25°C		0.4	18	- μΑ
	I _{DSS}	V _{DS} =1200V, V _{GS} =0V, T _J =175°C		10		
Total gate leakage current	I _{GSS}	V _{DS} =0V, T _J =25°C, V _{GS} =-20V / +20V		6	20	μΑ
Drain-source on-resistance	R _{DS(on)}	V _{GS} =12V, I _D =20A, T _J =25°C		72	91	
		V _{GS} =12V, I _D =20A, T _J =125°C		140		mΩ
		V _{GS} =12V, I _D =20A, T _J =175°C		197		
Gate threshold voltage	V _{G(th)}	V_{DS} =5V, I_{D} =10mA	4	4.8	6	V
Gate resistance	R _G	f=1MHz, open drain		4.5		Ω

Typical Performance - Reverse Diode

Parameter	Symbol	Test Conditions	Value			Units
Parameter			Min	Тур	Max	Units
Diode continuous forward current $^{\rm 1}$	۱ _s	T _C =25°C			27.5	А
Diode pulse current ²	I _{S,pulse}	T _C =25°C			83	А
	V _{FSD}	V _{GS} =0V, I _F =10A, T _J =25°C		1.43	1.64	
Forward voltage		V _{GS} =0V, I _F =10A, T _J =175°C		2.38		
Reverse recovery charge	Q _{rr}	V _R =800V, I _S =20A, V _{GS} =0V, R _G =20Ω,		119		nC
Reverse recovery time	t _{rr}	di/dt=1600A/µs, T_=25°C		14		ns
Reverse recovery charge	Q _{rr}	V _R =800V, I _S =20A, V _{GS} =0V, R _G =20Ω,		129		nC
Reverse recovery time	t _{rr}	di/dt=1600A/µs, T_j=150°C		14		ns



Typical Performance - Dynamic

Parameter	Symbol	Test Conditions	Value			Units
Parameter			Min	Тур	Max	Units
Input capacitance	C _{iss}			1370		
Output capacitance	C _{oss}	V _{DS} =800V, V _{GS} =0V f=100kHz		35		pF
Reverse transfer capacitance	C _{rss}			2		
Effective output capacitance, energy related	C _{oss(er)}	V _{DS} =0V to 800V, V _{GS} =0V		42		pF
Effective output capacitance, time related	C _{oss(tr)}	V _{DS} =0V to 800V, V _{GS} =0V		71		pF
C _{OSS} stored energy	E _{oss}	V_{DS} =800V, V_{GS} =0V		13.4		μJ
Total gate charge	Q_G	V -900V L -20A		37.8		
Gate-drain charge	Q_{GD}	$V_{DS} = 800V, I_{D} = 20A,$ $V_{GS} = 0V \text{ to } 15V$		9.5		nC
Gate-source charge	Q_{GS}	V _{GS} - 0V to 15V		10		
Turn-on delay time	t _{d(on)}	Note 4, V _{DS} =800V, I _D =20A, Gate		20		
Rise time	t _r			33		
Turn-off delay time	t _{d(off)}	Driver =0V to +15V, $R_{G OFF}$ =50 Ω		167		ns
Fall time	t _f	$R_{G_{ON}}=10\Omega$, inductive		15		
Turn-on energy	E _{ON}	Load, FWD: same device with $V_{GS} = 0V$ and $R_{G} = -$		434		
Turn-off energy	E _{OFF}	50Ω ,		49		μJ
Total switching energy	E _{TOTAL}	TT		483		-
Turn-on delay time	t _{d(on)}	Note 4,		28		
Rise time	t _r	V _{DS} =800V, I _D =20A, Gate		22		1
Turn-off delay time	$t_{d(off)}$	Driver =0V to +15V, R _{G OFF} =50Ω		177		ns
Fall time	t _f	$R_{G_{ON}}=10\Omega$, inductive		16		
Turn-on energy	E _{ON}	Load, FWD: same device with V_{GS} = OV and R_{G} =		523		
Turn-off energy	E _{OFF}	$= 50\Omega,$		131		μJ
Total switching energy	E _{TOTAL}	TJ=150°C		654		1

4. Measured with the half-bridge mode switching test circuit in Figure 22.





Typical Performance - Dynamic (continued)

Parameter	Symbol	T I C I'I'	Value			
		Test Conditions	Min	Тур	Max	Units
Turn-on delay time	t _{d(on)}	Note 5 and 6, V _{DS} =800V, I _D =20A, Gate		18		_
Rise time	t _r			20		
Turn-off delay time	t _{d(off)}	Driver =0V to +15V,		34		- ns
Fall time	t _f	$R_{G_{OFF}}=1\Omega$		9		
Turn-on energy including R _s energy	E _{ON}	$R_{G_ON}=5\Omega, Snubber:$ $R_{s}=10\Omega, C_{s}=95pF,$ inductive Load, FWD: same device with V _{GS} $= 0V \text{ and } R_{G} = 50\Omega, ,$ $T_{1}=25^{\circ}C$		501		
Turn-off energy including R _s energy	E _{OFF}			84		1
Total switching energy	E _{total}			585		μJ
Snubber R _s energy during turn-on	E _{RS_ON}			4.5		_
Snubber R _s energy during turn-off	E _{RS_OFF}			5.9		
Turn-on delay time	t _{d(on)}			20		
Rise time	t _r	Note 5 and 6, V _{DS} =800V, I _D =20A, Gate		22		1
Turn-off delay time	t _{d(off)}	Driver =0V to +15V,		36		ns
Fall time	t _f	$R_{G_{OFF}}=1\Omega$		10		1
Turn-on energy including R _s energy	E _{ON}	$= R_{G_ON} = 5\Omega, \text{ Snubber:}$ $= R_s = 10\Omega, C_s = 95\text{pF},$		518		
Turn-off energy including R _s energy	E _{OFF}	$FWD: same device with V_{GS}$ $= 0V and R_{G} = 50\Omega, ,$ $T_{J}=150^{\circ}C$		88		μ
Total switching energy	E _{TOTAL}			606		
Snubber R _s energy during turn-on	E _{RS_ON}			4.5		
Snubber R _s energy during turn-off	E _{RS_OFF}			6.7		1

5. Measured with the switching test circuit in Figure 23.

6. In this datasheet, all the switching energies (turn-on energy, turn-off energy and total energy) presented in the tables and Figures include the device RC snubber energy losses.



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Typical Performance Diagrams

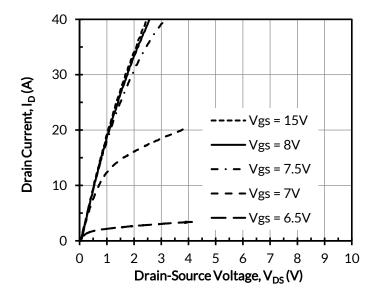


Figure 1. Typical output characteristics at T $_{\rm J}$ = - 55°C, tp < 250 μs

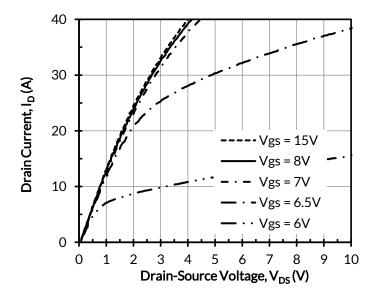


Figure 2. Typical output characteristics at T $_{\rm J}$ = 25°C, tp $< 250 \mu s$

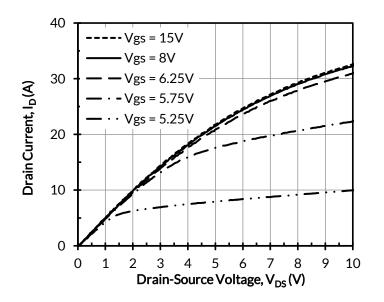


Figure 3. Typical output characteristics at $T_{\rm J}$ = 175°C, tp < 250 μs

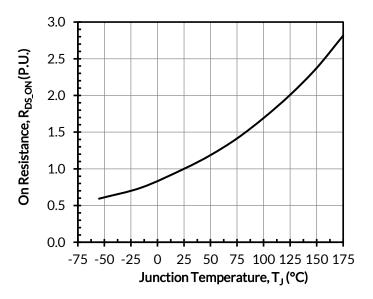


Figure 4. Normalized on-resistance vs. temperature at V_{GS} = 12V and I_{D} = 20A

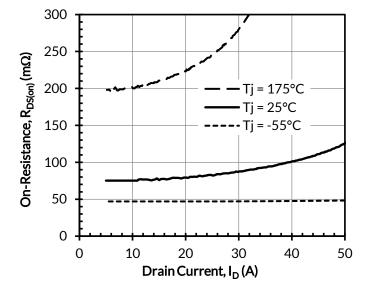
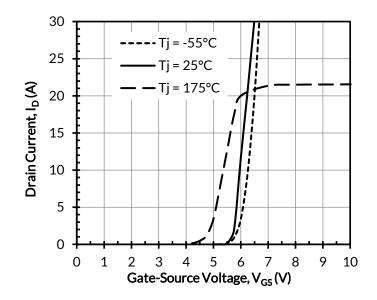


Figure 5. Typical drain-source on-resistances at V_{GS} = 12V



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Figure 6. Typical transfer characteristics at V_{DS} = 5V

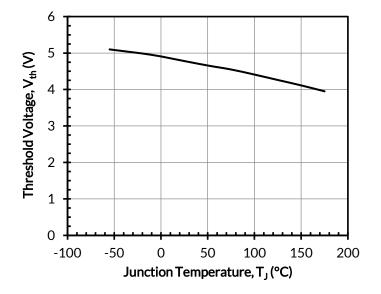


Figure 7. Threshold voltage vs. junction temperature at V_{DS} = 5V and I_{D} = 10mA

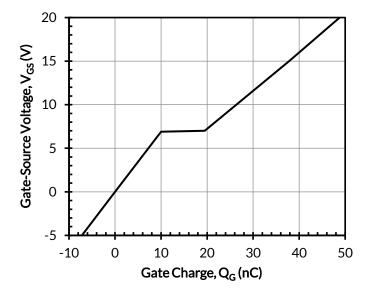
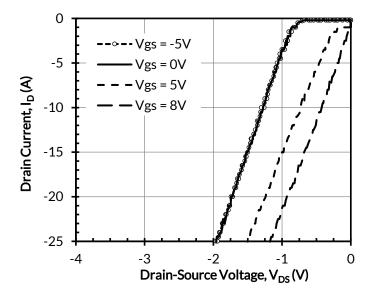


Figure 8. Typical gate charge at $I_{\rm D}$ = 20A and $V_{\rm DS}$ =400V



0 Vgs = - 5V -5 Vgs = 0V Vgs = 5V Drain Current, I_D (A) Vgs = 8V -10 -15 -20 -25 -3 -2 -1 0 -4 Drain-Source Voltage, V_{DS} (V)

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Figure 9. 3rd quadrant characteristics at $T_J = -55^{\circ}C$

Figure 10. 3rd quadrant characteristics at $T_J = 25^{\circ}C$

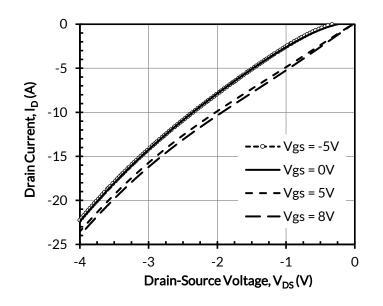


Figure 11. 3rd quadrant characteristics at T_J = 175°C

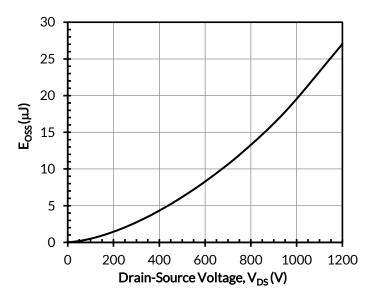


Figure 12. Typical stored energy in C_{OSS} at V_{GS} = 0V

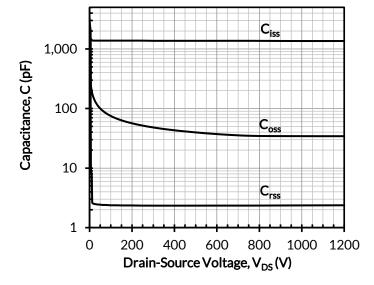


Figure 13. Typical capacitances at f = 100kHz and V_{GS} = 0V

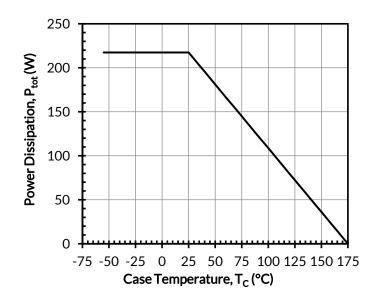
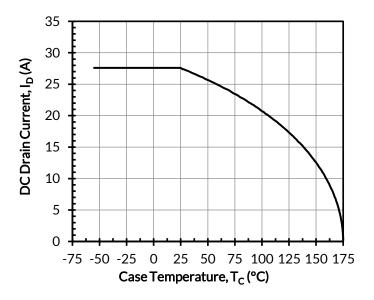


Figure 15. Total power dissipation



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Figure 14. DC drain current derating

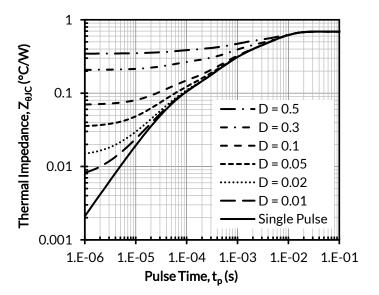


Figure 16. Maximum transient thermal impedance

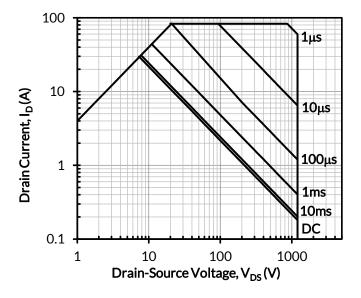
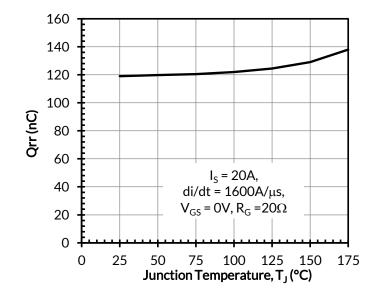


Figure 17. Safe operation area at T_C = 25°C, D = 0, Parameter t_p



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Figure 18. Reverse recovery charge Qrr vs. junction temperature at V_{DS} = 800V

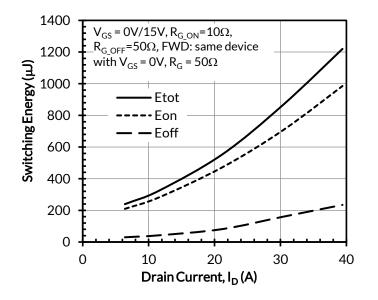


Figure 19. Clamped inductive switching energy vs. drain current at V_{DS} = 400V and T_J = 25°C

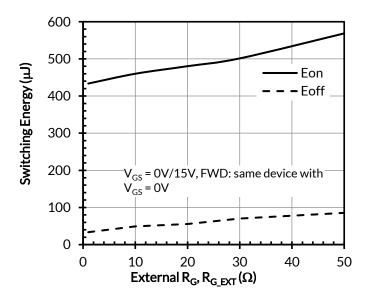


Figure 20. Clamped inductive switching energies vs. $R_{G,EXT}$ at V_{DS} = 800V, I_D =20A, and T_J = 25°C

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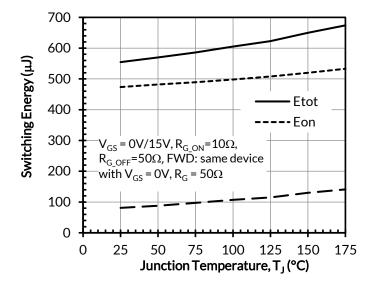


Figure 21. Clamped inductive switching energy vs. junction temperature at V_{DS} =800V and I_D =20A

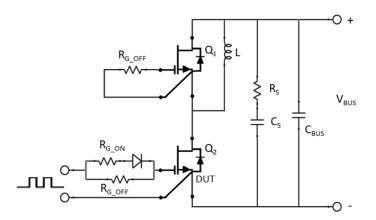


Figure 22. Schematic of the half-bridge mode switching test circuit. Note, a bus RC snubber ($R_s = 2.5\Omega$, $C_s=100$ nF) is used to reduce the power loop high frequency oscillations.

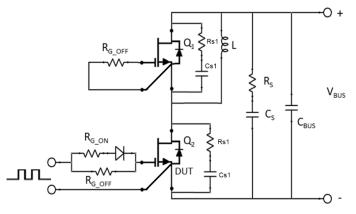


Figure 23. Schematic of the half-bridge mode switching test circuit with device RC snubbers ($R_{s1} = 10\Omega$, $C_{s1} = 95pF$) and a bus RC snubber ($R_s = 2.5\Omega$, $C_s = 100nF$).





Applications Information

SiC FETs are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ($R_{DS(on)}$), output capacitance (C_{oss}), gate charge (Q_G), and reverse recovery charge (Q_{rr}) leading to low conduction and switching losses. The SiC FETs also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the FET is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on SiC FET operation, see www.unitedsic.com.

A snubber circuit with a small $R_{(G)}$, or gate resistor, provides better EMI suppression with higher efficiency compared to using a high $R_{(G)}$ value. There is no extra gate delay time when using the snubber circuitry, and a small $R_{(G)}$ will better control both the turn-off $V_{(DS)}$ peak spike and ringing duration, while a high $R_{(G)}$ will damp the peak spike but result in a longer delay time. In addition, the total switching loss when using a snubber circuit is less than using high $R_{(G)}$, while greatly reducing $E_{(OFF)}$ from mid-to-full load range with only a small increase in $E_{(ON)}$. Efficiency will therefore improve with higher load current. For more information on how a snubber circuit will improve overall system performance, visit the UnitedSiC website at www.unitedsic.com

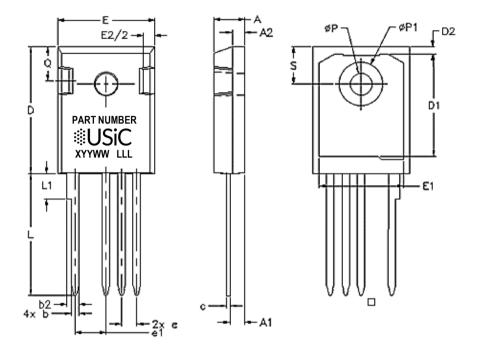
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TO-247-4L PACKAGE OUTLINE, PART MARKING AND TUBE SPECIFICATIONS

PACKAGE OUTLINE



DIM	INC	HES	MILLIMETERS		
	MIN	MAX	MIN	MAX	
A	0.185	0.209	4.7	5.31	
A1	0.087	0.102	2.21	2.59	
A2	0.059	0.098	1.5	2.49	
b	0.039	0.055	0.99	1.4	
b2	0.065	0.094	1.65	2.39	
С	0.015	0.035	0.38	0.89	
D	0.819	0.845	20.8	21.46	
D1	0.515	-	13.08	-	
D2	0.02	0.053	0.51	1.35	
E	0.61	0.64	15.49	16.26	
e	0.100 BSC		2.54 BSC		
e1	0.19	0.21	4.83	5.33	
E1	0.53	-	13.46	-	
E2	0.14	0.16	3.56	4.06	
L	0.78	0.8	19.81	20.32	
L1	-	0.177	-	4.5	
ФР	0.14	0.144	3.56	3.66	
ΦΡ1	0.278	0.291	7.06	7.39	
Q	0.212	0.244	5.38	6.2	
S	0.243 BSC		6.17 BSC		



TO-247-4L PACKAGE OUTLINE, PART MARKING AND TUBE SPECIFICATIONS

PART NUMBER = REFER TO DS_PN DECODER FOR DETAILS X = ASSEMBLY SITE

YY = YEAR WW = WORK WEEK LLL = LOT ID

PACKING TYPE

ANTI-STATIC TUBE

QUANTITY /TUBE : 30 UNITS

XYYWW

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